

**Search Notes**

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Joon H. Hwang

Applicant(s)/Patent under  
Reexamination

AIDA ET AL.

Art Unit

2166

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Palm see search history printout(s)	2/1/2007	JH